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Modeling and Fabrication of Micromachined Inductors

by

Seung-Jin Yoo, B. E.

Thesis

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Modeling and Fabrication of Micromachined Inductors

Approved by Supervising Committee: Dean P. Neikirk, Supervisor

Jack C. Lee

Dedication

This thesis is dedicated to my wife, Hee-sun Han and My parents, Tae-Rho Yoo and Kyu-Ja Han.

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Abstract

Modeling and Fabrication of Micromachined Inductors

Seung-Jin Yoo, M. S. E

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Supervisor: Dean P. Neikirk

In this work, micromachining technology is adopted to enhance the

performance of planar inductors. Good inductors frequently require two main

factors: high self resonant frequencies and high quality factors. By removing the

entire silicon substrate underneath an integrated inductor, the effect of parasitic

capacitance and resistive loss due to substrate conductivity can be removed,

dramatically improving performance at high frequency (RF and Microwave

regime).

A model of an inductor on silicon is presented to explain the effect of

frequency and substrate conductivity on inductor performance. Removing the

substrate for enhancing inductor performance is justified by the proposed model

and experimental investigation.

Various fabrication issues and techniques for the micromachined inductor

are studied as well.

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